Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	0
10/576,553	DERCKX ET AL.	
Examiner	Art Unit	
Y. J. Han	2838	

	SEAR	CHED	
Class	Subclass	Date	Examiner
323	222 225 267 271 272 284 351	11/9/2007	JH
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PLUS	11/9/2007	JH		
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